

# SCAN90CP02 1.5 Gbps 2x2 LVDS Crosspoint Switch with Pre-Emphasis and IEEE 1149.6

Check for Samples: [SCAN90CP02](#)

## FEATURES

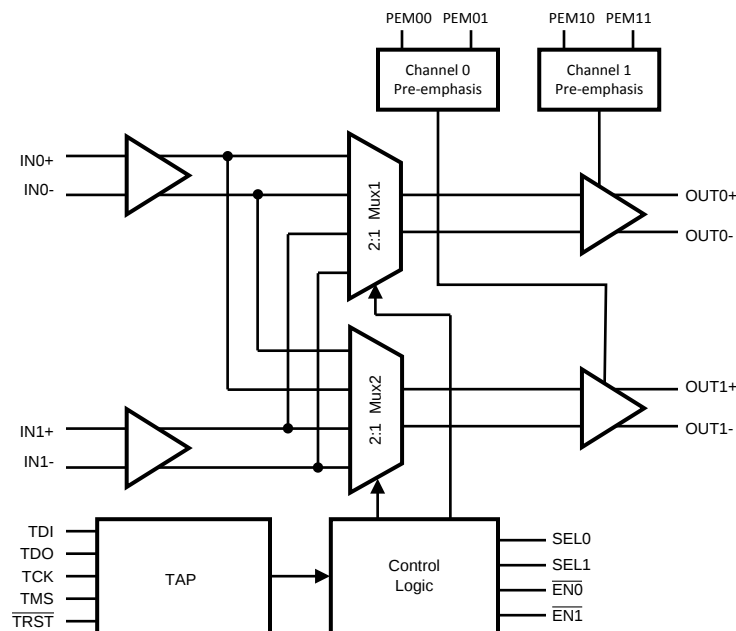
- 1.5 Gbps per Channel
- Low Power: 70 mA in Dual Repeater Mode @1.5 Gbps
- Low Output Jitter
- Configurable 0/25/50/100% Pre-Emphasis Drives Lossy Backplanes and Cables
- Non-Blocking Architecture Allows 1:2 Splitter, 2:1 Mux, Crossover, and Dual Buffer Configurations
- Flow-Through Pinout
- LVDS/BLVDS/CML/LVPECL Inputs, LVDS Outputs
- IEEE 1149.1 and 1149.6 Compliant
- Single 3.3V Supply
- Separate Control of Inputs and Outputs Allows for Power Savings
- Industrial -40 to +85°C Temperature Range
- 28-Lead UQFN Package, or 32-Lead LQFP Package

## DESCRIPTION

The SCAN90CP02 is a 1.5 Gbps 2 x 2 LVDS crosspoint switch. High speed data paths and flow-through pinout minimize internal device jitter, while configurable 0/25/50/100% pre-emphasis overcomes external ISI jitter effects of lossy backplanes and cables. The differential inputs interface to LVDS and Bus LVDS signals such as those on TI's 10-, 16-, and 18-bit Bus LVDS SerDes, as well as CML and LVPECL. The SCAN90CP02 can also be used with ASICs and FPGAs. The non-blocking crosspoint architecture is pin-configurable as a 1:2 clock or data splitter, 2:1 redundancy mux, crossover function, or dual buffer for signal booster and stub hider applications.

Integrated IEEE 1149.1 (JTAG) and 1149.6 circuitry supports testability of both single-ended LVTTL/CMOS and differential LVDS PCB interconnect. The 3.3V supply, CMOS process, and LVDS I/O ensure high performance at low power over the entire industrial -40 to +85°C temperature range.

## Block Diagram



**Figure 1. SCAN90CP02 Block Diagram**



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

All trademarks are the property of their respective owners.

## PIN DESCRIPTIONS

| Pin Name                                       | UQFN Pin Number          | LQFP Pin Number             | I/O, Type | Description                                                                                                                                                                                                                                                                                                           |
|------------------------------------------------|--------------------------|-----------------------------|-----------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| <b>DIFFERENTIAL INPUTS COMMON TO ALL MUXES</b> |                          |                             |           |                                                                                                                                                                                                                                                                                                                       |
| IN0+<br>IN0–                                   | 9<br>10                  | 9<br>10                     | I, LVDS   | Inverting and non-inverting differential inputs. LVDS, Bus LVDS, CML, or LVPECL compatible.                                                                                                                                                                                                                           |
| IN1+<br>IN1–                                   | 12<br>13                 | 13<br>14                    | I, LVDS   | Inverting and non-inverting differential inputs. LVDS, Bus LVDS, CML, or LVPECL compatible.                                                                                                                                                                                                                           |
| <b>SWITCHED DIFFERENTIAL OUTPUTS</b>           |                          |                             |           |                                                                                                                                                                                                                                                                                                                       |
| OUT0+<br>OUT0–                                 | 27<br>26                 | 32<br>31                    | O, LVDS   | Inverting and non-inverting differential outputs. OUT0± can be connected to any one pair IN0±, or IN1±. LVDS compatible <sup>(1)</sup> .                                                                                                                                                                              |
| OUT1+<br>OUT1–                                 | 24<br>23                 | 28<br>27                    | O, LVDS   | Inverting and non-inverting differential outputs. OUT1± can be connected to any one pair IN0±, or IN1±. LVDS compatible <sup>(1)</sup> .                                                                                                                                                                              |
| <b>DIGITAL CONTROL INTERFACE</b>               |                          |                             |           |                                                                                                                                                                                                                                                                                                                       |
| SEL0,<br>SEL1                                  | 6<br>5                   | 7<br>6                      | I, LVTTTL | Select Control Inputs                                                                                                                                                                                                                                                                                                 |
| EN0, EN1                                       | 7<br>15                  | 8<br>17                     | I, LVTTTL | Output Enable Inputs                                                                                                                                                                                                                                                                                                  |
| PEM00,<br>PEM01                                | 4<br>3                   | 4<br>3                      | I, LVTTTL | Channel 0 Output Pre-emphasis Control Inputs                                                                                                                                                                                                                                                                          |
| PEM10,<br>PEM11                                | 2<br>1                   | 2<br>1                      | I, LVTTTL | Channel 1 Output Pre-emphasis Control Inputs                                                                                                                                                                                                                                                                          |
| TDI                                            | 19                       | 22                          | I, LVTTTL | Test Data Input to support IEEE 1149.1 features                                                                                                                                                                                                                                                                       |
| TDO                                            | 20                       | 23                          | O, LVTTTL | Test Data Output to support IEEE 1149.1 features                                                                                                                                                                                                                                                                      |
| TMS                                            | 18                       | 21                          | I, LVTTTL | Test Mode Select to support IEEE 1149.1 features                                                                                                                                                                                                                                                                      |
| TCK                                            | 17                       | 19                          | I, LVTTTL | Test Clock to support IEEE 1149.1 features                                                                                                                                                                                                                                                                            |
| TRST                                           | 21                       | 24                          | I, LVTTTL | Test Reset to support IEEE 1149.1 features                                                                                                                                                                                                                                                                            |
| N/C                                            | 8, 28                    |                             |           | Not Connected                                                                                                                                                                                                                                                                                                         |
| <b>POWER</b>                                   |                          |                             |           |                                                                                                                                                                                                                                                                                                                       |
| V <sub>DD</sub>                                | 11, 14,<br>16, 22,<br>25 | 12, 16,<br>18, 25,<br>29    | I, Power  | V <sub>DD</sub> = 3.3V ±0.3V. At least 4 low ESR 0.01 µF bypass capacitors should be connected from V <sub>DD</sub> to GND plane.                                                                                                                                                                                     |
| GND                                            | See <sup>(2)</sup>       | 5, 11, 15,<br>20, 26,<br>30 |           | Ground reference to LVDS and CMOS circuitry.<br>For the UQFN package, the DAP is used as the primary GND connection to the device. The DAP is the exposed metal contact at the bottom of the UQFN-28 package. It should be connected to the ground plane with at least 4 vias for optimal AC and thermal performance. |

(1) The LVDS outputs do not support a multidrop (BLVDS) environment. The LVDS output characteristics of the SCAN90CP02 device have been optimized for point-to-point backplane and cable applications.

(2) Note that for the UQFN package GND is not an actual pin on the package, the GND is connected thru the DAP on the back side of the UQFN package.

## Connection Diagrams

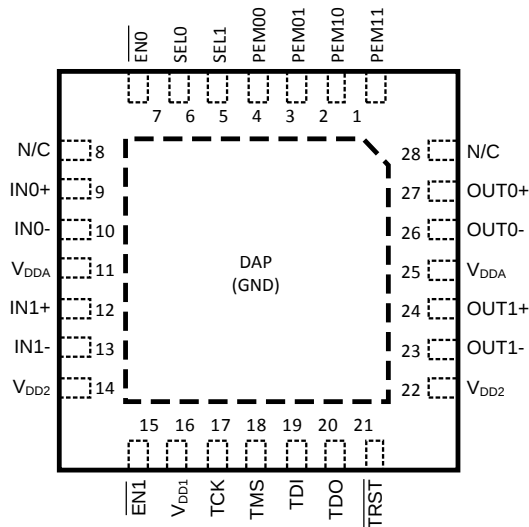


Figure 2. UQFN Top View  
DAP = GND

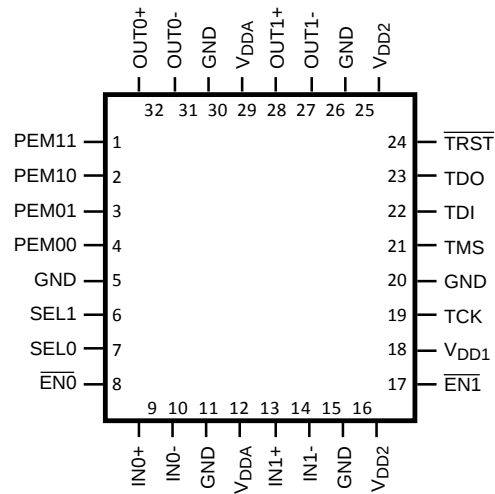


Figure 3. LQFP Top View

### CONFIGURATION SELECT TRUTH TABLE<sup>(1)</sup>

| SEL0 | SEL1 | EN0 | EN1 | OUT0 | OUT1 | Mode                                              |
|------|------|-----|-----|------|------|---------------------------------------------------|
| 0    | 0    | 0   | 0   | IN0  | IN0  | 1:2 Splitter (IN1 powered down)                   |
| 0    | 1    | 0   | 0   | IN0  | IN1  | Dual Channel Repeater                             |
| 1    | 0    | 0   | 0   | IN1  | IN0  | Dual Channel Switch                               |
| 1    | 1    | 0   | 0   | IN1  | IN1  | 1:2 Splitter (IN0 powered down)                   |
| 0    | 1    | 0   | 1   | IN0  | PD   | Single Channel Repeater (Channel 1 powered down)  |
| 1    | 1    | 0   | 1   | IN1  | PD   | Single Channel Switch (IN0 and OUT1 powered down) |
| 0    | 0    | 1   | 0   | PD   | IN0  | Single Channel Switch (IN1 and OUT0 powered down) |
| 0    | 1    | 1   | 0   | PD   | IN1  | Single Channel Repeater (Channel 0 powered down)  |
| X    | X    | 1   | 1   | PD   | PD   | Both Channels in Power Down Mode                  |
| 0    | 0    | 0   | 1   |      |      | Invalid State <sup>(2)</sup>                      |
| 1    | 0    | 0   | 1   |      |      | Invalid State <sup>(2)</sup>                      |
| 1    | 0    | 1   | 0   |      |      | Invalid State <sup>(2)</sup>                      |
| 1    | 1    | 1   | 0   |      |      | Invalid State <sup>(2)</sup>                      |

(1) PD = Power Down mode to minimize power consumption

X = Don't Care

(2) Entering these states is not forbidden, however device operation is not defined in these states.

## PRE-EMPHASIS

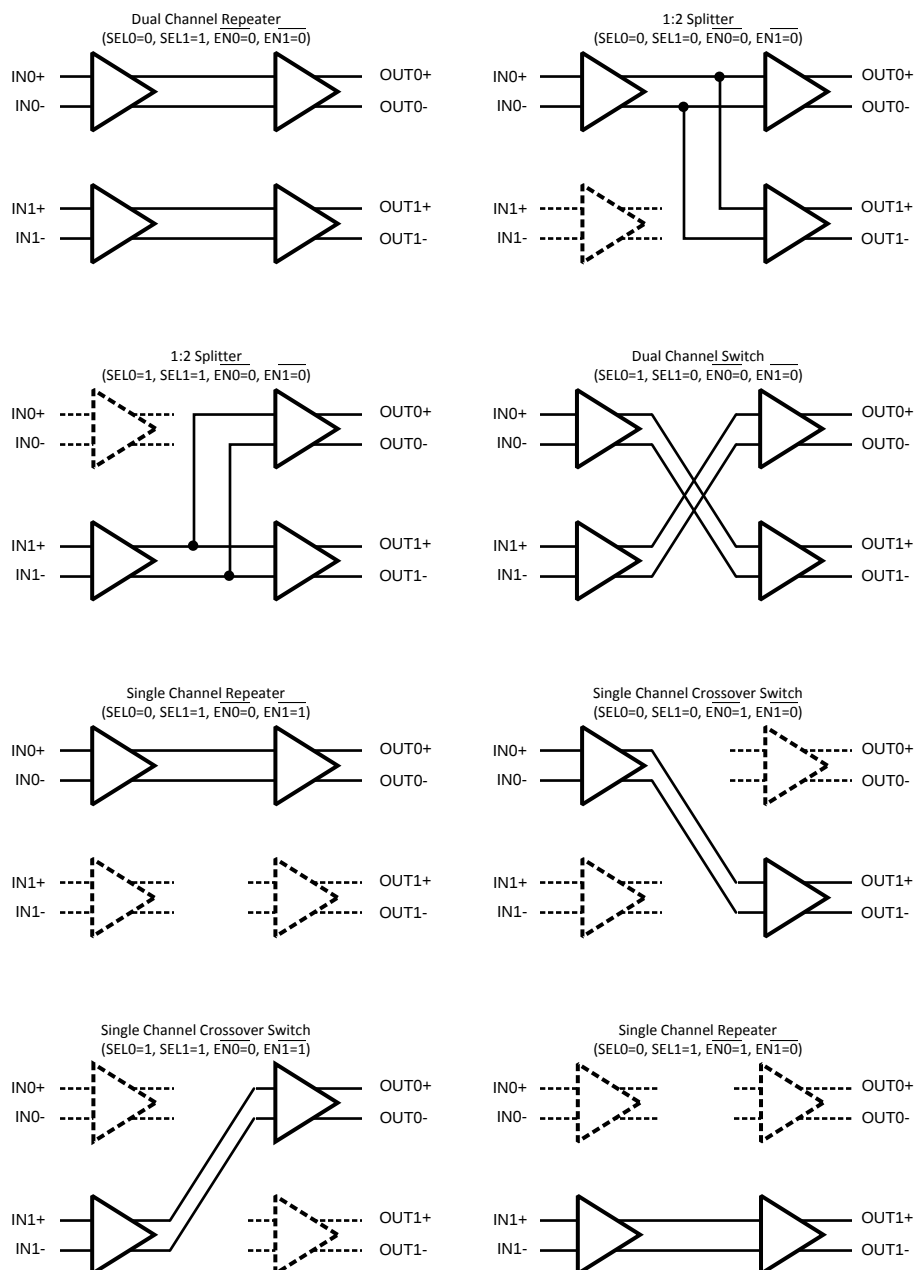
The pre-emphasis is used to compensate for long or lossy transmission media. Separate pins are provided for each output to minimize power consumption. Pre-emphasis is programmable to be off or to preset values per [Table 1](#).

## Output Characteristics

The output characteristics of the SCAN90CP02 device have been optimized for point-to-point backplane and cable applications.

**Table 1. Pre-emphasis Control Selection Table**

| Channel 0 |       | Channel 1 |       | Pre-emphasis |
|-----------|-------|-----------|-------|--------------|
| PEM01     | PEM00 | PEM11     | PEM10 |              |
| 0         | 0     | 0         | 0     | 0%           |
| 0         | 1     | 0         | 1     | 25%          |
| 1         | 0     | 1         | 0     | 50%          |
| 1         | 1     | 1         | 1     | 100%         |

**Applications Information****Figure 4. SCAN90CP02 Configuration Select Decode**



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## ABSOLUTE MAXIMUM RATINGS<sup>(1)(2)</sup>

|                                           |                              |                              |
|-------------------------------------------|------------------------------|------------------------------|
| Supply Voltage ( $V_{DD}$ )               |                              | -0.3V to +4.0V               |
| CMOS Input Voltage                        |                              | -0.3V to ( $V_{DD} + 0.3V$ ) |
| LVDS Receiver Input Voltage               |                              | -0.3V to +3.6V               |
| LVDS Driver Output Voltage                |                              | -0.3V to +3.6V               |
| LVDS Output Short Circuit Current         |                              | 40mA                         |
| Junction Temperature                      |                              | +150°C                       |
| Storage Temperature                       |                              | -65°C to +150°C              |
| Lead Temperature (Soldering, 4sec.)       |                              | +260°C                       |
| Maximum Package Power Dissipation at 25°C | UQFN-28                      | 4.31 W                       |
|                                           | LQFP-32                      | 1.47 W                       |
| Derating above 25°C                       | UQFN-28                      | 34.5 mW/°C                   |
|                                           | LQFP-32                      | 11.8 mW/°C                   |
| Thermal Resistance, $\theta_{JA}$         | UQFN-28                      | 29°C/W                       |
|                                           | LQFP-32                      | 85°C/W                       |
| ESD Rating                                | HBM, 1.5 k $\Omega$ , 100 pF | 6.5 kV                       |
|                                           | EIAJ, 0 $\Omega$ , 200 pF    | >250V                        |

- (1) "Absolute Maximum Ratings" are the ratings beyond which the safety of the device cannot be specified. They are not meant to imply that the device should be operated at these limits.
- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.

## RECOMMENDED OPERATING CONDITIONS

|                                  | Min | Typ | Max | Unit |
|----------------------------------|-----|-----|-----|------|
| Supply Voltage ( $V_{DD}$ – GND) | 3.0 | 3.3 | 3.6 | V    |
| Receiver Input Voltage           | 0   |     | 3.6 | V    |
| Operating Free Air Temperature   | -40 | 25  | 85  | °C   |
| Junction Temperature             |     |     | 150 | °C   |

## ELECTRICAL CHARACTERISTICS

Over recommended operating supply and temperature ranges unless other specified.

| Symbol                                                                                                                                           | Parameter                       | Conditions                                 | Min          | Typ <sup>(1)</sup> | Max      | Units   |
|--------------------------------------------------------------------------------------------------------------------------------------------------|---------------------------------|--------------------------------------------|--------------|--------------------|----------|---------|
| <b>LVTTL DC SPECIFICATIONS</b> (SEL0, SEL1, $\overline{EN1}$ , $\overline{EN2}$ , PEM00, PEM01, PEM10, PEM11, TDI, TCK, TMS, $\overline{TRST}$ ) |                                 |                                            |              |                    |          |         |
| $V_{IH}$                                                                                                                                         | High Level Input Voltage        |                                            | 2.0          |                    | $V_{DD}$ | V       |
| $V_{IL}$                                                                                                                                         | Low Level Input Voltage         |                                            | GND          |                    | 0.8      | V       |
| $I_{IH}$                                                                                                                                         | High Level Input Current        | $V_{IN} = V_{DD} = V_{DDMAX}$              | -10          |                    | +10      | $\mu A$ |
| $I_{IL}$                                                                                                                                         | Low Level Input Current         | $V_{IN} = V_{SS}$ , $V_{DD} = V_{DDMAX}$   | -10          |                    | +10      | $\mu A$ |
| $I_{ILR}$                                                                                                                                        | Low Level Input Current         | TDI, TMS, $\overline{TRST}$                | -40          |                    | -200     | $\mu A$ |
| $C_{IN1}$                                                                                                                                        | Input Capacitance               | Any Digital Input Pin to $V_{SS}$          |              | 3.5                |          | pF      |
| $C_{OUT1}$                                                                                                                                       | Output Capacitance              | Any Digital Output Pin to $V_{SS}$         |              | 5.5                |          | pF      |
| $V_{CL}$                                                                                                                                         | Input Clamp Voltage             | $I_{CL} = -18$ mA                          | -1.5         | -0.8               |          | V       |
| $V_{OH}$                                                                                                                                         | High Level Output Voltage (TDO) | $I_{OH} = -12$ mA, $V_{DD} = 3.0$ V        | 2.4          |                    |          | V       |
|                                                                                                                                                  |                                 | $I_{OH} = -100$ $\mu A$ , $V_{DD} = 3.0$ V | $V_{DD}-0.2$ |                    |          | V       |
| $V_{OL}$                                                                                                                                         | Low Level Output Voltage (TDO)  | $I_{OL} = 12$ mA, $V_{DD} = 3.0$ V         |              |                    | 0.5      | V       |
|                                                                                                                                                  |                                 | $I_{OL} = 100$ $\mu A$ , $V_{DD} = 3.0$ V  |              |                    | 0.2      | V       |
| $I_{OS}$                                                                                                                                         | Output Short Circuit Current    | TDO                                        | -15          |                    | -125     | mA      |

- (1) Typical parameters are measured at  $V_{DD} = 3.3V$ ,  $T_A = 25^\circ C$ . They are for reference purposes, and are not production-tested.

## ELECTRICAL CHARACTERISTICS (continued)

Over recommended operating supply and temperature ranges unless other specified.

| Symbol                                                      | Parameter                                                   | Conditions                                                                                                                                           | Min  | Typ <sup>(1)</sup> | Max   | Units |
|-------------------------------------------------------------|-------------------------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------|------|--------------------|-------|-------|
| LVDS INPUT DC SPECIFICATIONS (IN0±, IN1±)                   |                                                             |                                                                                                                                                      |      |                    |       |       |
| V <sub>TH</sub>                                             | Differential Input High Threshold <sup>(2)</sup>            | V <sub>CM</sub> = 0.8V or 1.2V or 3.55V, V <sub>DD</sub> = 3.6V                                                                                      |      | 0                  | 100   | mV    |
| V <sub>TL</sub>                                             | Differential Input Low Threshold                            | V <sub>CM</sub> = 0.8V or 1.2V or 3.55V, V <sub>DD</sub> = 3.6V                                                                                      | −100 | 0                  |       | mV    |
| V <sub>ID</sub>                                             | Differential Input Voltage                                  | V <sub>CM</sub> = 0.8V to 3.55V, V <sub>DD</sub> = 3.6V                                                                                              | 100  |                    |       | mV    |
| V <sub>CMR</sub>                                            | Common Mode Voltage Range                                   | V <sub>ID</sub> = 150 mV, V <sub>DD</sub> = 3.6V                                                                                                     | 0.05 |                    | 3.55  | V     |
| C <sub>IN2</sub>                                            | Input Capacitance                                           | IN+ or IN− to V <sub>SS</sub>                                                                                                                        |      | 3.5                |       | pF    |
| I <sub>IN</sub>                                             | Input Current                                               | V <sub>IN</sub> = 3.6V, V <sub>DD</sub> = V <sub>DDMAX</sub> or 0V                                                                                   | −10  |                    | +10   | μA    |
|                                                             |                                                             | V <sub>IN</sub> = 0V, V <sub>DD</sub> = V <sub>DDMAX</sub> or 0V                                                                                     | −10  |                    | +10   | μA    |
| LVDS OUTPUT DC SPECIFICATIONS (OUT0±, OUT1±)                |                                                             |                                                                                                                                                      |      |                    |       |       |
| V <sub>OD</sub>                                             | Differential Output Voltage, 0% Pre-emphasis <sup>(2)</sup> | R <sub>L</sub> = 100Ω between OUT+ and OUT−                                                                                                          | 250  | 400                | 575   | mV    |
| ΔV <sub>OD</sub>                                            | Change in V <sub>OD</sub> between Complementary States      |                                                                                                                                                      | −35  |                    | 35    | mV    |
| V <sub>OS</sub>                                             | Offset Voltage <sup>(3)</sup>                               |                                                                                                                                                      | 1.09 | 1.25               | 1.475 | V     |
| ΔV <sub>OS</sub>                                            | Change in V <sub>OS</sub> between Complementary States      |                                                                                                                                                      | −35  |                    | 35    | mV    |
| I <sub>OS</sub>                                             | Output Short Circuit Current, One Complementary Output      | OUT+ or OUT− Short to GND                                                                                                                            |      | −60                | −90   | mA    |
| C <sub>OUT2</sub>                                           | Output Capacitance                                          | OUT+ or OUT− to GND when TRI-STATE                                                                                                                   |      | 5.5                |       | pF    |
| SUPPLY CURRENT (Static)                                     |                                                             |                                                                                                                                                      |      |                    |       |       |
| I <sub>CC0</sub>                                            | Supply Current                                              | All inputs and outputs enabled and active, terminated with differential load of 100Ω between OUT+ and OUT−.                                          |      | 42                 | 60    | mA    |
| I <sub>CC1</sub>                                            | Supply Current - one channel powered down                   | Single channel crossover switch or single channel repeater modes (1 channel active, one channel in power down mode)                                  |      | 22                 | 30    | mA    |
| I <sub>CC2</sub>                                            | Supply Current - one input powered down                     | Splitter mode (One input powered down, both outputs active)                                                                                          |      | 30                 | 40    | mA    |
| I <sub>CCZ</sub>                                            | TRI-STATE Supply Current                                    | Both input/output Channels in Power Down Mode                                                                                                        |      | 1.4                | 2.5   | mA    |
| SWITCHING CHARACTERISTICS—LVDS OUTPUTS (Figure 5, Figure 6) |                                                             |                                                                                                                                                      |      |                    |       |       |
| t <sub>LHT</sub>                                            | Differential Low to High Transition Time                    | Use an alternating 1 and 0 pattern at 200 Mb/s, measure between 20% and 80% of V <sub>OD</sub> .                                                     | 70   | 150                | 215   | ps    |
| t <sub>HLT</sub>                                            | Differential High to Low Transition Time                    |                                                                                                                                                      | 50   | 135                | 180   | ps    |
| t <sub>PLHD</sub>                                           | Differential Low to High Propagation Delay                  | Use an alternating 1 and 0 pattern at 200 Mb/s, measure at 50% V <sub>OD</sub> between input to output.                                              | 0.5  | 2.4                | 3.5   | ns    |
| t <sub>PHLD</sub>                                           | Differential High to Low Propagation Delay                  |                                                                                                                                                      | 0.5  | 2.4                | 3.5   | ns    |
| t <sub>SKD1</sub>                                           | Pulse Skew                                                  | t <sub>PLHD</sub> −t <sub>PHLD</sub>                                                                                                                 |      | 55                 | 120   | ps    |
| t <sub>SKCC</sub>                                           | Output Channel to Channel Skew                              | Difference in propagation delay (t <sub>PLHD</sub> or t <sub>PHLD</sub> ) among all output channels in Splitter mode (any one input to all outputs). | 0    | 130                | 315   | ps    |

(2) Differential output voltage V<sub>OD</sub> is defined as ABS(OUT+–OUT–). Differential input voltage V<sub>ID</sub> is defined as ABS(IN+–IN–).

(3) Output offset voltage V<sub>OS</sub> is defined as the average of the LVDS single-ended output voltages at logic high and logic low states.

## ELECTRICAL CHARACTERISTICS (continued)

Over recommended operating supply and temperature ranges unless other specified.

| Symbol    | Parameter                                | Conditions                                                                                  | Min  | Typ <sup>(1)</sup> | Max | Units |
|-----------|------------------------------------------|---------------------------------------------------------------------------------------------|------|--------------------|-----|-------|
| $t_{JIT}$ | Jitter (0% Pre-emphasis) <sup>(4)</sup>  | RJ - Alternating 1/0 @ 750 MHz <sup>(5)</sup>                                               |      | 1.4                | 2.5 | psrms |
|           |                                          | DJ - K28.5 Pattern<br>1.5 Gbps <sup>(6)</sup>                                               | LQFP | 110                | 140 | psp-p |
|           |                                          |                                                                                             | UQFN | 42                 | 75  | psp-p |
|           |                                          | TJ - PRBS 2 <sup>23</sup> -1 Pattern<br>1.5 Gbps <sup>(7)</sup>                             | LQFP | 113                | 148 | psp-p |
|           |                                          |                                                                                             | UQFN | 93                 | 126 | psp-p |
| $t_{ON}$  | LVDS Output Enable Time                  | Time from $\overline{ENx}$ to OUT $\pm$ change from TRI-STATE to active.                    | 50   | 110                | 150 | ns    |
| $t_{OFF}$ | LVDS Output Disable Time                 | Time from $\overline{ENx}$ to OUT $\pm$ change from active to TRI-STATE.                    |      | 5                  | 12  | ns    |
| $t_{SW}$  | LVDS Switching Time<br>SELx to OUT $\pm$ | Time from configuration select (SELx) to new switch configuration effective for OUT $\pm$ . |      | 110                | 150 | ns    |

(4) Jitter is not production tested, but specified through characterization on a sample basis.

(5) Random Jitter, or RJ, is measured RMS with a histogram including 1500 histogram window hits. The input voltage =  $V_{ID}$  = 500mV, 50% duty cycle at 750MHz,  $t_r = t_f = 50ps$  (20% to 80%).

(6) Deterministic Jitter, or DJ, is measured to a histogram mean with a sample size of 350 hits. The input voltage =  $V_{ID}$  = 500mV, K28.5 pattern at 1.5 Gbps,  $t_r = t_f = 50ps$  (20% to 80%). The K28.5 pattern is repeating bit streams of (0011111010 1100000101).

(7) Total Jitter, or TJ, is measured peak to peak with a histogram including 3500 window hits. Stimulus and fixture jitter has been subtracted. The input voltage =  $V_{ID}$  = 500mV, 2<sup>23</sup>-1 PRBS pattern at 1.5 Gbps,  $t_r = t_f = 50ps$  (20% to 80%).

## SCAN CIRCUITRY TIMING REQUIREMENTS

| Symbol    | Parameter                               | Conditions                                  | Min  | Typ | Max | Units |
|-----------|-----------------------------------------|---------------------------------------------|------|-----|-----|-------|
| $f_{MAX}$ | Maximum TCK Clock Frequency             | $R_L = 500\Omega$ ,<br>$C_L = 35\text{ pF}$ | 25.0 |     |     | MHz   |
| $t_S$     | TDI to TCK, H or L                      |                                             | 1.0  |     |     | ns    |
| $t_H$     | TDI to TCK, H or L                      |                                             | 2.0  |     |     | ns    |
| $t_S$     | TMS to TCK, H or L                      |                                             | 2.0  |     |     | ns    |
| $t_H$     | TMS to TCK, H or L                      |                                             | 1.5  |     |     | ns    |
| $t_W$     | TCK Pulse Width, H or L                 |                                             | 10.0 |     |     | ns    |
| $t_W$     | $\overline{TRST}$ Pulse Width, L        |                                             | 2.5  |     |     | ns    |
| $t_{REC}$ | Recovery Time, $\overline{TRST}$ to TCK |                                             | 2.0  |     |     | ns    |

## TIMING DIAGRAMS

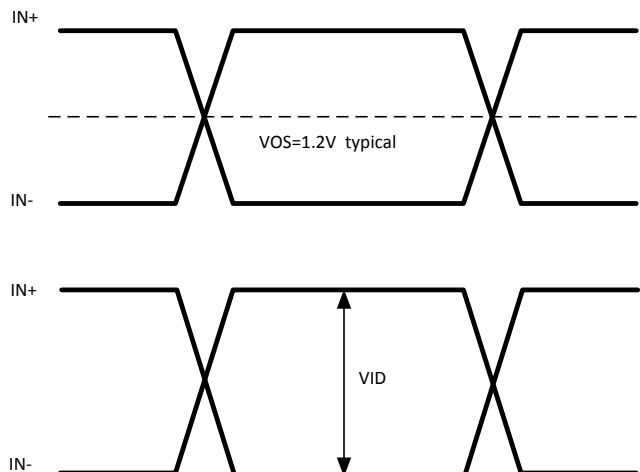


Figure 5. LVDS Signals

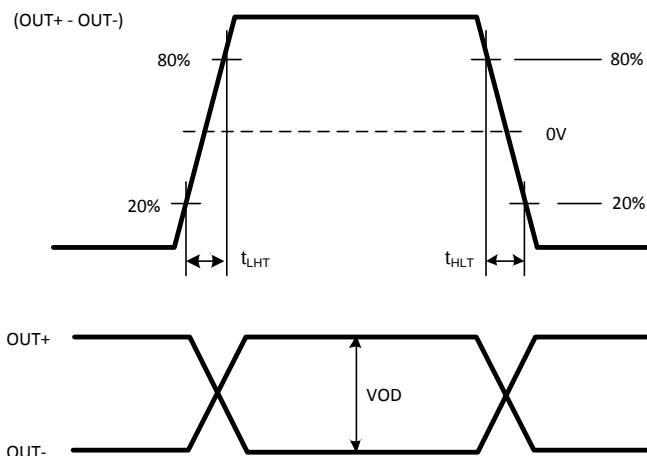


Figure 6. LVDS Output Transition Time

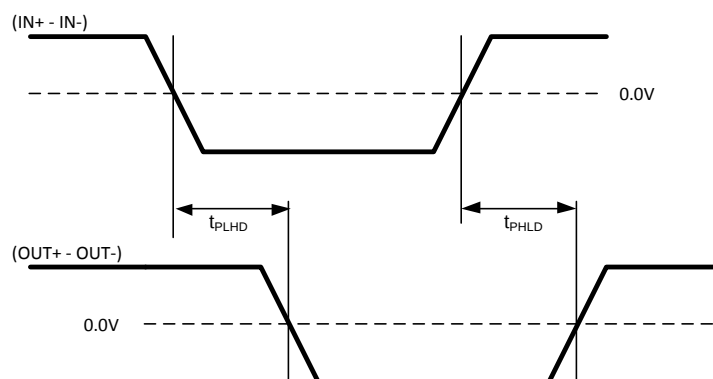


Figure 7. LVDS Output Propagation Delay

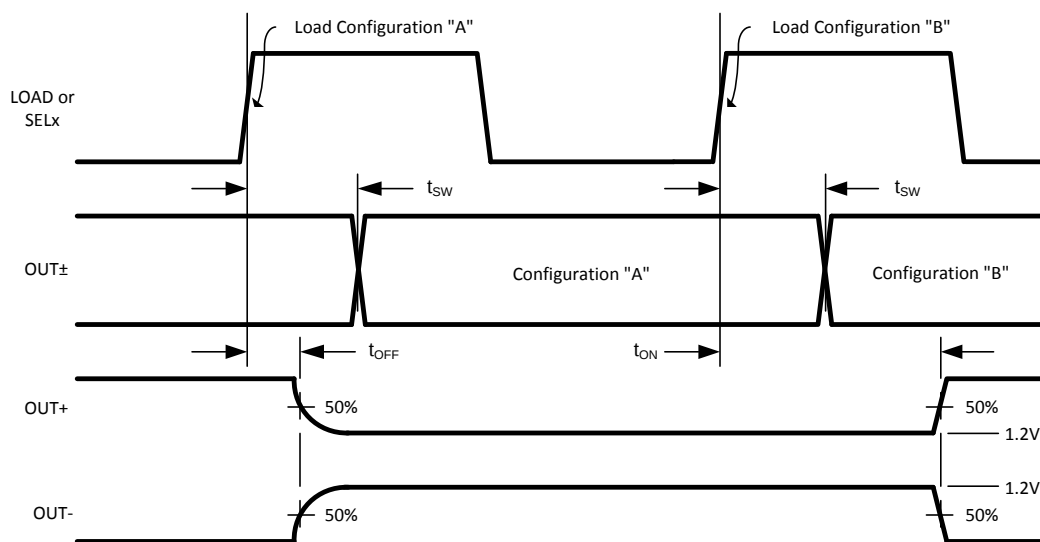


Figure 8. Configuration and Output Enable/Disable Timing

## Input Interfacing

The SCAN90CP02 accepts differential signals and allow simple AC or DC coupling. With a wide common mode range, the SCAN90CP02 can be DC-coupled with all common differential drivers (i.e. LVPECL, LVDS, CML). The following three figures illustrate typical DC-coupled interface to common differential drivers.

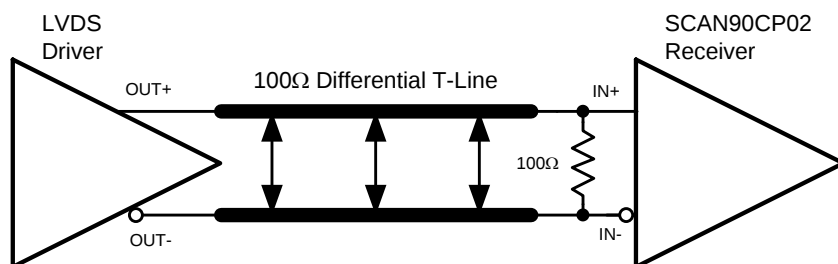


Figure 9. Typical LVDS Driver DC-Coupled Interface to SCAN90CP02 Input

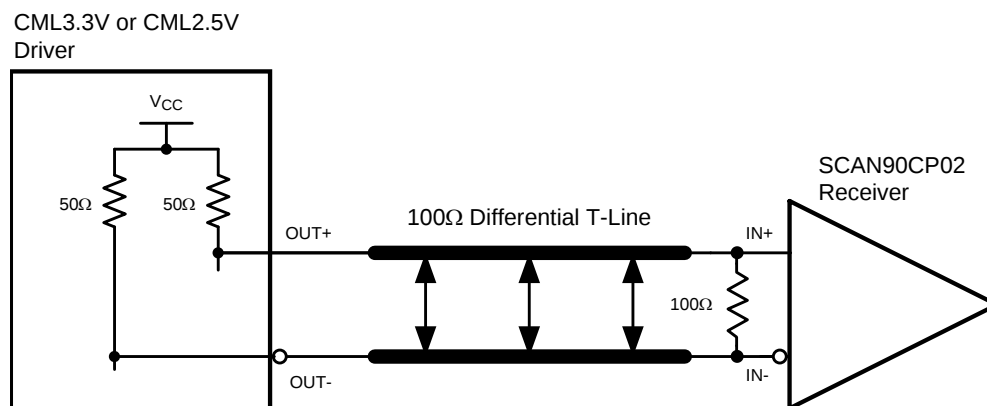


Figure 10. Typical CML Driver DC-Coupled Interface to SCAN90CP02 Input

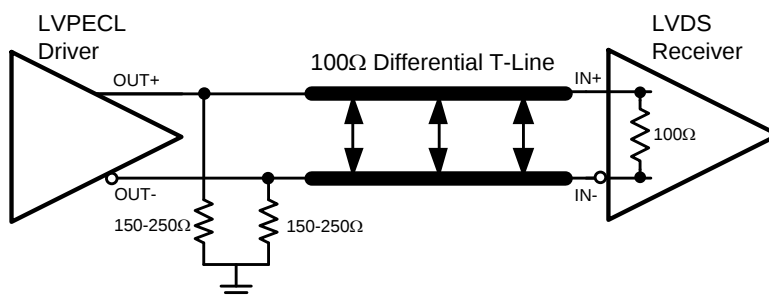


Figure 11. Typical LVPECL Driver DC-Coupled Interface to SCAN90CP02 Input

## Output Interfacing

The SCAN90CP02 outputs signals that are compliant to the LVDS standard. Their outputs can be DC-coupled to most common differential receivers. Figure 12 illustrates typical DC-coupled interface to common differential receivers and assumes that the receivers have high impedance inputs. While most differential receivers have a common mode input range that can accommodate LVDS compliant signals, it is recommended to check respective receiver's data sheet prior to implementing the suggested interface implementation.

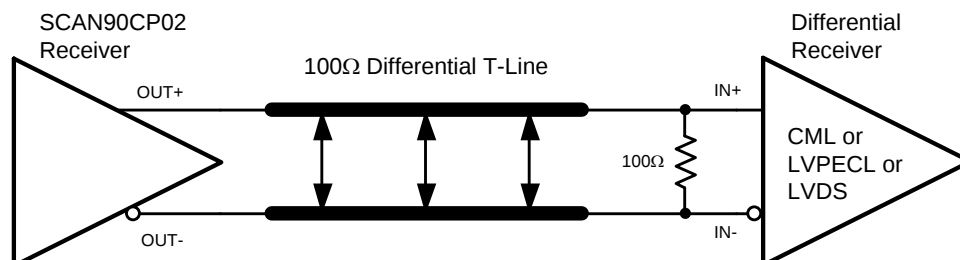
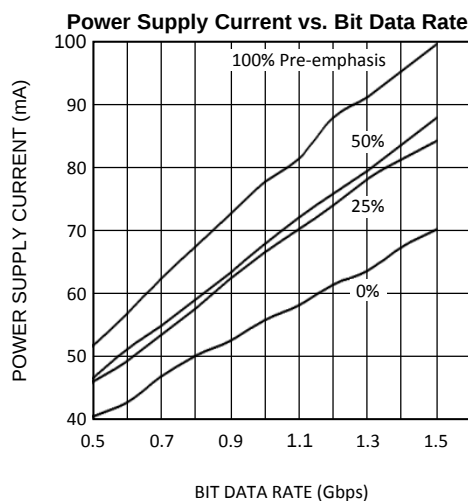


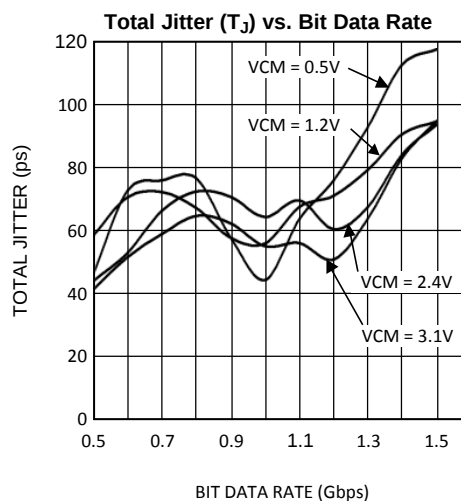
Figure 12. Typical SCAN90CP02 Output DC-Coupled Interface to an LVDS, CML or LVPECL Receiver

## TYPICAL PERFORMANCE CHARACTERISTICS FOR UQFN PACKAGE



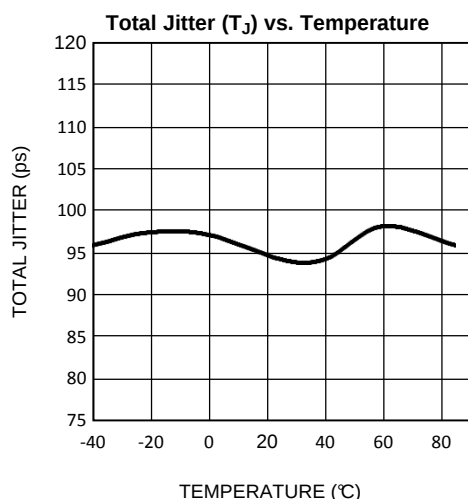
Dynamic power supply current was measured while running a PRBS  $2^{23}-1$  pattern in dual channel repeater mode.  $V_{CC} = 3.3V$ ,  $T_A = +25^{\circ}C$ ,  $V_{ID} = 0.5V$ ,  $V_{CM} = 1.2V$

Figure 13.



Total Jitter measured at 0V differential while running a PRBS  $2^{23}-1$  pattern in single channel repeater mode.  $V_{CC} = 3.3V$ ,  $T_A = +25^{\circ}C$ ,  $V_{ID} = 0.5V$ , 0% Pre-emphasis

Figure 14.



Total Jitter measured at 0V differential while running a PRBS  $2^{23}-1$  pattern in dual channel repeater mode.  $V_{CC} = 3.3V$ ,  $V_{ID} = 0.5V$ ,  $V_{CM} = 1.2V$ , 1.5 Gbps data rate, 0% Pre-emphasis

Figure 15.

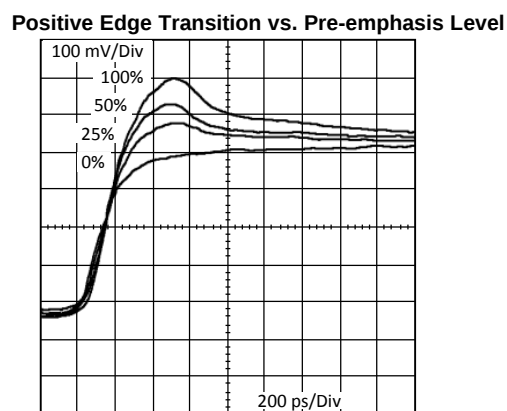


Figure 16.

## DESIGN-FOR-TEST (DFT) FEATURES

### IEEE 1149.1 SUPPORT

The SCAN90CP02 supports a fully compliant IEEE 1149.1 interface. The Test Access Port (TAP) provides access to boundary scan cells at each LVTTTL I/O on the device for interconnect testing. Differential pins are included in the same boundary scan chain but instead contain IEEE1149.6 cells. IEEE1149.6 is the improved IEEE standard for testing high-speed differential signals.

Refer to the BSDL file located on TI's website for the details of the SCAN90CP02 IEEE 1149.1 implementation.

### IEEE 1149.6 SUPPORT

AC-coupled differential interconnections on very high speed (1+ Gbps) data paths are not testable using traditional IEEE 1149.1 techniques. The IEEE 1149.1 structures and methods are intended to test static (DC-coupled), single ended networks. IEEE1149.6 is specifically designed for testing high-speed differential, including AC coupled networks.

The SCAN90CP02 is intended for high-speed signaling up to 1.5 Gbps and includes IEEE1149.6 on all differential inputs and outputs.

### FAULT INSERTION

Fault Insertion is a technique used to assist in the verification and debug of diagnostic software. During system testing faults are "injected" to simulate hardware failure and thus help verify the monitoring software can detect and diagnose these faults. In the SCAN90004 an IEEE1149.1 "stuck-at" instruction can create a stuck-at condition, either high or low, on any pin or combination of pins.

A more detailed description of the stuck-at feature can be found in Texas Instruments Applications note AN-1313([SNLA060](#)).

## REVISION HISTORY

### Changes from Revision L (April 2013) to Revision M

### Page

- Changed layout of National Data Sheet to TI format ..... [12](#)

## PACKAGING INFORMATION

| Orderable part number             | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier   | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|-----------------------------------|---------------|----------------------|-----------------|-------------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">SCAN90CP02SP/NOPB</a> | Active        | Production           | UQFN (NJD)   28 | 1000   SMALL T&R        | Yes         | SN                                   | Level-3-260C-168 HR               | -40 to 85    | SCP02SP             |
| SCAN90CP02SP/NOPB.A               | Active        | Production           | UQFN (NJD)   28 | 1000   SMALL T&R        | Yes         | SN                                   | Level-3-260C-168 HR               | -40 to 85    | SCP02SP             |
| <a href="#">SCAN90CP02VY/NOPB</a> | Active        | Production           | LQFP (NEY)   32 | 250   JEDEC TRAY (10+1) | Yes         | SN                                   | Level-3-260C-168 HR               | -40 to 85    | SCAN90 CP02VY       |
| SCAN90CP02VY/NOPB.A               | Active        | Production           | LQFP (NEY)   32 | 250   JEDEC TRAY (10+1) | Yes         | SN                                   | Level-3-260C-168 HR               | -40 to 85    | SCAN90 CP02VY       |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## TAPE AND REEL INFORMATION



\*All dimensions are nominal

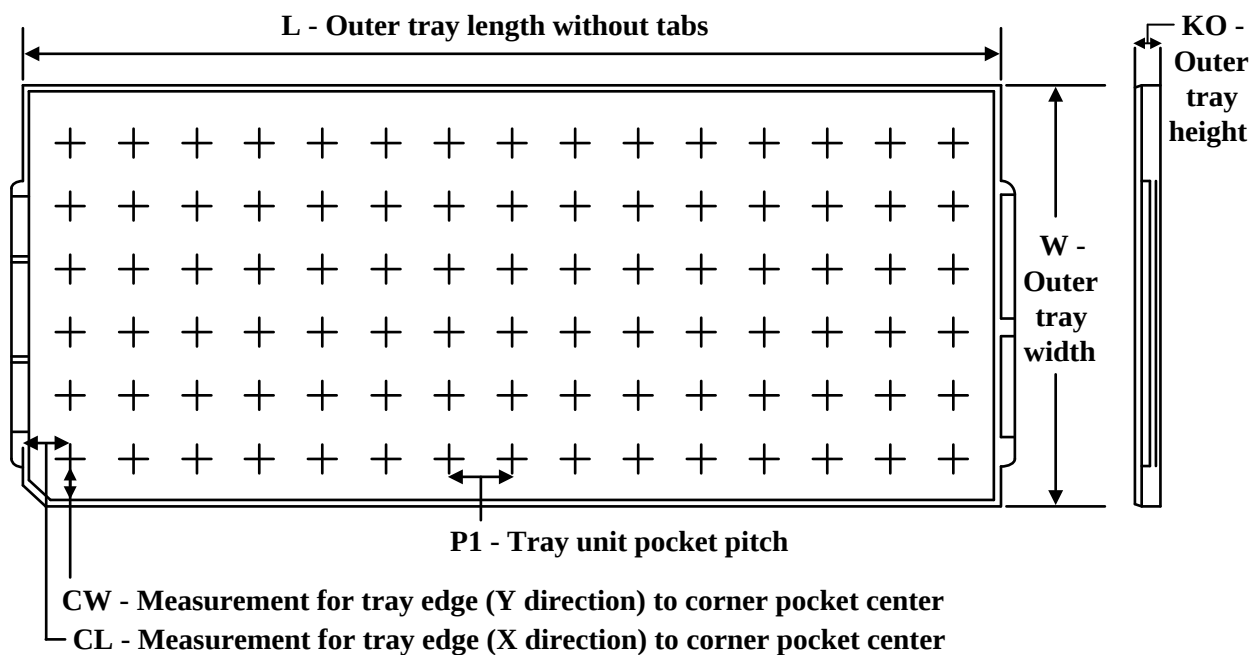
| Device            | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| SCAN90CP02SP/NOPB | UQFN         | NJD             | 28   | 1000 | 177.8              | 12.4               | 5.3     | 5.3     | 1.3     | 8.0     | 12.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device            | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| SCAN90CP02SP/NOPB | UQFN         | NJD             | 28   | 1000 | 208.0       | 191.0      | 35.0        |

**TRAY**


Chamfer on Tray corner indicates Pin 1 orientation of packed units.

\*All dimensions are nominal

| Device              | Package Name | Package Type | Pins | SPQ | Unit array matrix | Max temperature (°C) | L (mm) | W (mm) | K0 (μm) | P1 (mm) | CL (mm) | CW (mm) |
|---------------------|--------------|--------------|------|-----|-------------------|----------------------|--------|--------|---------|---------|---------|---------|
| SCAN90CP02VY/NOPB   | NEY          | LQFP         | 32   | 250 | 10 x 25           | 150                  | 315    | 135.9  | 7620    | 12.2    | 11.1    | 11.25   |
| SCAN90CP02VY/NOPB.A | NEY          | LQFP         | 32   | 250 | 10 x 25           | 150                  | 315    | 135.9  | 7620    | 12.2    | 11.1    | 11.25   |

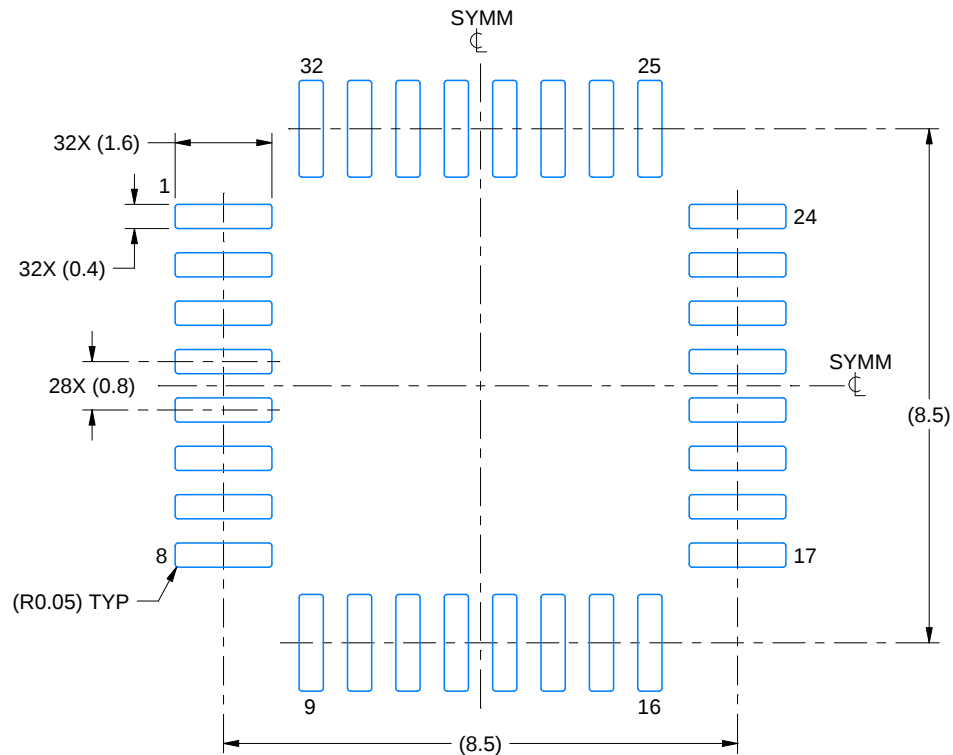


# EXAMPLE BOARD LAYOUT

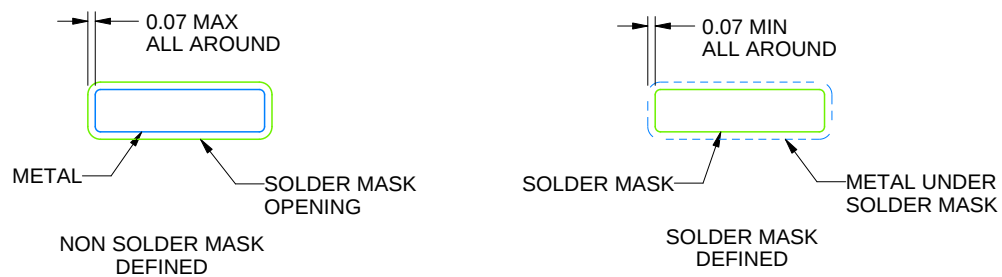
NEY0032A

LQFP - 1.6 mm max height

PLASTIC QUAD FLATPACK



LAND PATTERN EXAMPLE  
SCALE:8X



SOLDER MASK DETAILS

4219901/A 10/2016

NOTES: (continued)

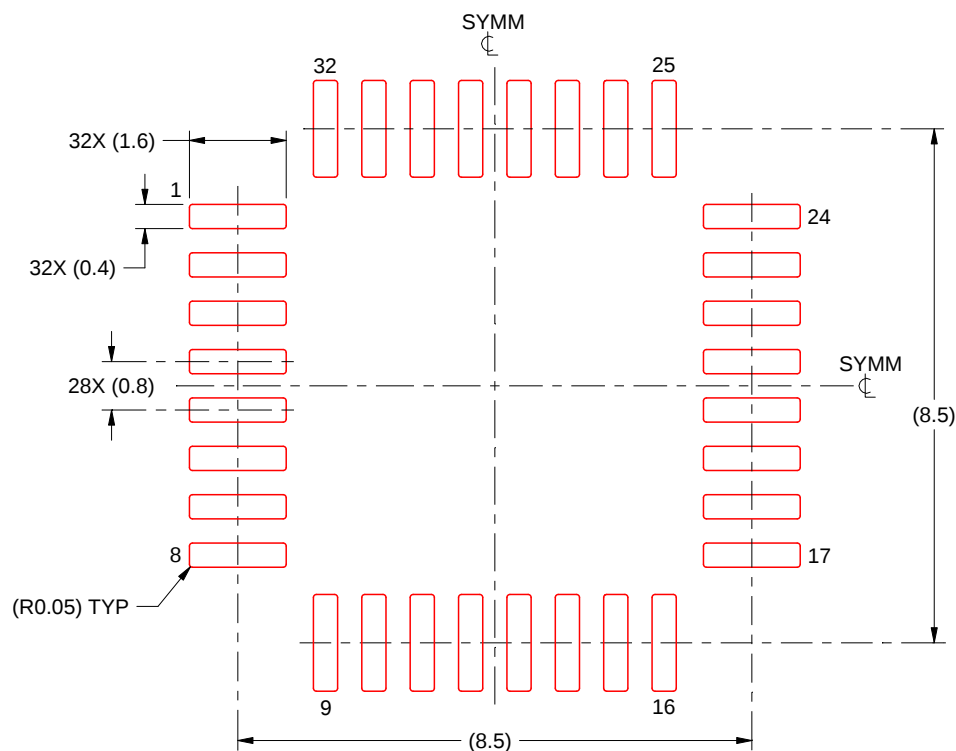
4. Publication IPC-7351 may have alternate designs.
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

NEY0032A

LQFP - 1.6 mm max height

PLASTIC QUAD FLATPACK



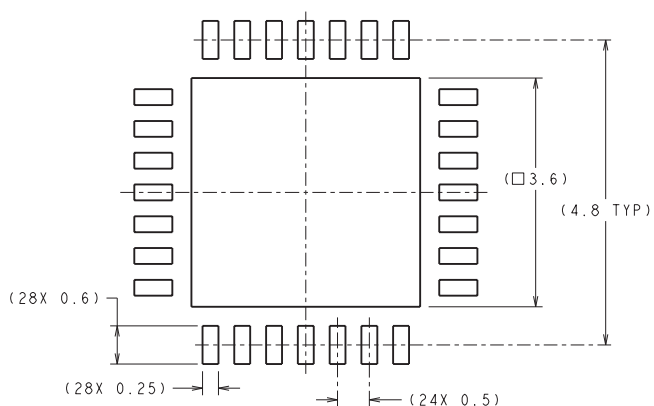
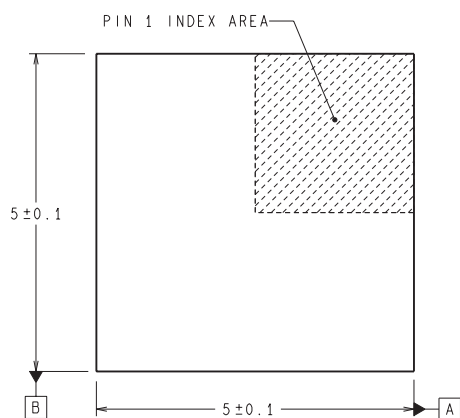
SOLDER PASTE EXAMPLE  
SCALE 8X

4219901/A 10/2016

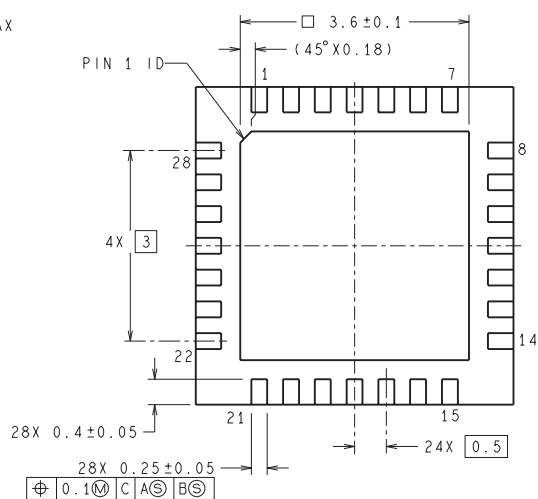
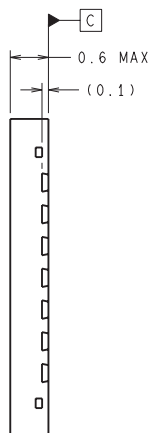
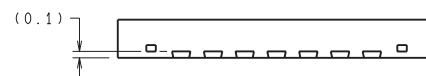
NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
7. Board assembly site may have different recommendations for stencil design.

NJD0028A

**RECOMMENDED LAND PATTERN**

**DIMENSIONS ARE IN MILLIMETERS**  
 DIMENSIONS IN ( ) FOR REFERENCE ONLY



SPA28A (Rev A)

## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to [TI's Terms of Sale](#), [TI's General Quality Guidelines](#), or other applicable terms available either on [ti.com](https://www.ti.com) or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025